TOSHIBA 2SC5256FT

TOSHIBA TRANSISTOR SILICON NPN EPITAXIAL PLANAR TYPE

2 S C 5 2 5 6 F T

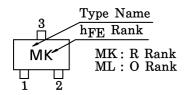
VHF~UHF BAND LOW NOISE AMPLIFIER APPLICATION

Low Noise Figure : NF = 1.5dB (f = 2GHz) $: |S_{21e}|^2 = 9.5 dB (f = 2GHz)$ High Gain

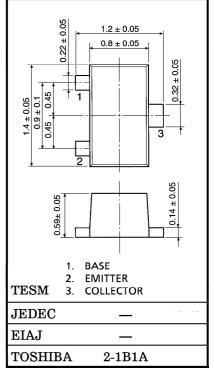
MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Collector-Base Voltage	V_{CBO}	15	V
Collector-Emitter Voltage	v_{CEO}	7	V
Emitter-Base Voltage	$V_{ m EBO}$	1.5	V
Collector Current	$I_{\mathbf{C}}$	40	mA
Base Current	I _B	20	mA
Collector Power Dissipation	PC	100	mW
Junction Temperature	T_{j}	125	°C
Storage Temperature Range	$T_{ m stg}$	-55~125	°C

MARKING



Unit in mm



MICROWAVE CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Transition Frequency	${ m f_T}$	$V_{CE}=5V, I_{C}=20mA$	9	12	_	GHz
Illngortion (ioin	$ S_{21e} ^2(1)$	$V_{CE}=5V$, $I_{C}=20$ mA, $f=1$ GHz	_	15	_	dB
	$ S_{21e} ^2$ (2)	V_{CE} =5V, I_{C} =20mA, f =2GHz	6.5	9.5	_	ub
I Noise Figure ⊢	NF (1)	$V_{CE}=5V$, $I_{C}=5mA$, $f=1GHz$	_	1.1	_	dB
	NF (2)	$V_{CE}=5V$, $I_{C}=5mA$, $f=2GHz$	_	1.5	3	us

ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Collector Cut-off Current	I_{CBO}	$V_{CB}=10V, I_{E}=0$	_	_	1	μ A
Emitter Cut-off Current	I _{EBO}	$V_{EB} = 1V, I_{C} = 0$	_	_	1	μ A
DC Current Gain	hFE (Note 1)	$V_{\text{CE}}=5V, I_{\text{C}}=20\text{mA}$	50	_	160	_
Output Capacitance	C_{ob}	$V_{CB} = 10V, I_{E} = 0, f = 1MHz$	_	0.65	_	рF
Reverse Transfer Capacitance	C_{re}	(Note 2)	_	0.5	0.95	pF

(Note 1): hFE Classification R:50~100, O:80~160

(Note 2): C_{re} is measured by 3 terminal method with capacitance bridge.

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